

LTT24 – fast, flexible and precise



LTT24 – High Speed measurement technology

Winner
of the
MESSTEC & SENSOR
Masters 2013
AWARD



The multifunctional, patented real-time data acquisition device LTT24 with 24 Bit ADC and 4 MSample/s per channel, including the functionality of a measuring amplifier for volts, current, ICP®, strain gage, charge, resistance, pulse, temperature etc.



Liquid metal flows



Electric motors



Tape drive replacement



Automotive industry



Power quality

LTT24 – up to 4 MHz at 24 Bit

AT FULL SPEED WITH HIGHEST PRECISION

- 24 Bit AD-conversion at up to 4 MHz sampling rate
- Digital measurements accurate to nanoseconds
- Pulse/counter inputs: 832 MHz Δ 1.20 ns resolution
- 20 Bit analog outputs up to 2 MHz

INCREDIBLY FLEXIBLE

- Recording with a PC or an internal SSD (500 GB)
- Modular housing concept 4, 8, 12, 16 channel inserts
- USB 3.0 | USB 2.0 and Gigabit Ethernet interface to PC
- Synchronization interface for device cascading of multiple LTT24 devices
- Digital I/O and synchronization interface
- Extendable at any time

INCREDIBLY PRECISE

- Best signal quality (16 ENOB – Effective Number of Bits)
- Best CMRR – Common Mode Rejection Ratio
- Best galvanic isolation
- Flat bandwidth: DC - 1 MHz or 1.7 MHz

HIGH PRECISION INPUTS AND OUTPUTS

- For volts, current, charge, ICP[®], strain gage, LVDT, resistance, also All-in-one
- Sensor supply output: constant voltage, constant current, carrier frequency
- Single-ended and differential-ended: AC or DC
- Status LEDs for all channels

SOFTWARE

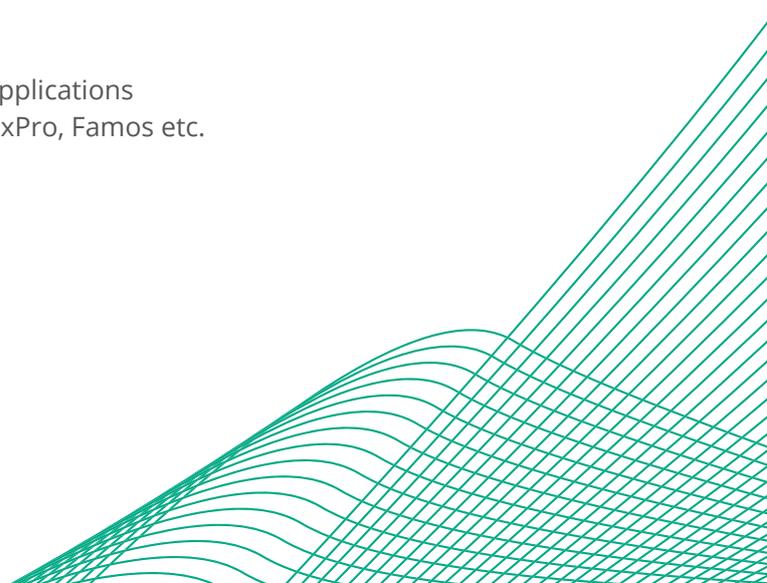
- LTTpro: Control and visualization software
- LTT2API: Library for integration into customer applications
- Compatible with DASyLab, LabVIEW, Matlab, FlexPro, Famos etc.



LTT24 front



LTT24 back



LTT24 – Fields of application

HIGH SPEED MEASUREMENT TECHNOLOGY IN USE

The LTT24 is used for a wide variety of applications in almost all industries. We will give you concrete examples of how you can benefit from our fast, flexible and precise measurement technology.



Military



Offshore
wind farms



Universities



EMC measurements
in rail traffic



OEM test bench
construction



Ultrasonic /
Underwater acoustics

www.tasler.de

FATIGUE AND CRACK DETECTION

Material tests with structure-borne sound, DMS, ICP® and charge



PRODUCTION MONITORING

Development of turbochargers



**POWER
MEASUREMENT**
on battery-powered
electric motors



TRANSIENT RECORDERS

with extensive
sensor support



AEROSPACE

Qualification test
of satellite systems



Labortechnik Tasler GmbH

Friedrich-Bergius-Ring 15
97076 Würzburg, Germany

Fon +49 931 359 610
Fax +49 931 359 6150

kontakt@tasler.de
www.tasler.de

LTT24 – Technical Data

Transient recorder including Sensor-Preamplifiers

Technical Specifications – Optional Specifications marked with *

Available Housings

LTT24-4	4 channel housing: 142 x 400 x 75 mm ³ / 3,7 kg
LTT24-8	8 channel housing: 244 x 400 x 75 mm ³ / 5,9 kg
LTT24-16	16 channel housing: 447 x 400 x 75 mm ³ / 10,4 kg

Data Transfer Rates

Internal SSD	256 MByte/s*
PC with USB	170 MByte/s (USB 3.0) 35 MByte/s (USB 2.0)
PC with Gigabit LAN	27 Mbyte/s*

Input Characteristics

Quantization	24 Bits
max. Sampling Rate	4 MSample/s per channel
max. Bandwidth	DC – 1.7 MHz
Filter	analog: 1.7 MHz low pass filter digital: a variety of selectable filters
Inter-Channel Phase Difference	< 1 ns
Input Connectors	BNC and DIN
Galvanic Isolation	±200 V
Volt Input Ranges	±250 mV, ±5 V, ±50 V, ±200 V*
Volt Input Impedance	1MΩ_50pF, [10MΩ_5pF at ±200 V]*
Volt Input Couplings	single-ended (AC/DC), differential (AC/DC)
Current Input	±50 mA range with internal 5 Ω shunt resistor

Number of Channels

max. No. of Channels per Device	4, 8 or 16 (dependent on housing)
max. No. of Devices	1024
Synchronization*	yes (max. delay between devices: ±1 ns)
External Clock*	1 input and 1 output with 3.3 V LVPECL
External Trigger*	1 input and 1 output with 5 V TTL
Digital Inputs*	16 inputs and 16 outputs with 5 V TTL

	Range	Bandwidth		
		5 kHz	50 kHz	1 MHz
Dynamic Range	±50 V	116 dB	110 dB	100 dB
	±5 V	118 dB	112 dB	101 dB
	±250 mV	105 dB	97 dB	85 dB
ENOB (THD + noise) effective number of bits	Range	effective bits	dB @ 125 kHz sampling rate	
	±50 V	typ 15.6 Bit	-96 dB	
	±5 V	typ 15.9 Bit	-98 dB	
	±250 mV	typ 14.6 Bit	-90 dB	
Crosstalk	< -120 dB (DC – 200 kHz)			
CMRR without Trimming common mode rejection ration	Range	0-20 kHz	0-100 kHz	0-1 MHz
	±250 mV	typ 95 dB	87 dB	70 dB
	±5 V	typ 88 dB	74 dB	55 dB
	±50 V	typ 78 dB	73 dB	53 dB
CMRR with Trimming* common mode rejection ration	Range	0-20 kHz	0-100 kHz	0-1 MHz
	±250 mV	> 100 dB	88 dB	70 dB
	±5 V	> 100 dB	75 dB	55 dB
	±50 V	> 100 dB	74 dB	53 dB
Input Protection	±17.5 V @ range ±250 mV, ±5 V; ±175 V @ range ±50 V; ±220 V @ range ±200 V			

Operating Conditions

Power Supply	12-16 VDC (absolute max. rating 10-35 VDC)
	11 W typical per channel without sensor supply
	external power supply: 100-240 VAC
Environmental Temperature	+10 °C to +40 °C
Extended Temperature Range	0 °C to + 50 °C on request
Operating System	Windows 7 / 8 / 10, Linux and others

Data Recording

RAM	32 MByte per channel 512 MByte RAM with 16 channels
Interface to PC	USB 3.0, USB 2.0, Gigabit Ethernet*
Recording Media	internal RAM, internal SSD*, PC's hard disk
Size of internal SSD	500 GB*

Signal Conditioning

Strain Gage*	full-, half-, quarter-bridge, sense, no sense constant voltage supply: 0 ... 10 V, 0 ... 20 V* input coupling: AC and DC
IEPE (ICP®)*	constant current supply: 0 ... 10 mA; input coupling: AC and DC
Resistance*	input coupling: AC and DC; 2-wire, 3-wire and 4-wire
Charge*	1 mV/pC, range: ±5 nC (optional up to ±500 nC) high-pass: 0.15 Hz; 1.5 Hz; 15 Hz auto charge clear; manual clear
LVDT*	carrier frequency with up to 100 kHz and 0 ... 5 V Amplitude synchronous demodulation; unipolar and bipolar output
Pulse/Counter Input*	signal input: ±30 V input coupling: AC and DC time resolution 1.20 ns (832 MHz) direction detection; zero marker

Analog Output Characteristics

No. of Channels per Device	one analog output channel for each analog input channel
Synchronization of several Devices	yes (max. delay between devices: 2 ns)
Sampling Rate	max. DAC rate 2 MSample/s per channel
max. Bandwidth	DC – 500 kHz
Quantization	18 Bit, 20 Bit*
Output Impedance	100 Ω
Connector	BNC
Galvanic Isolation	input to output of same channel: yes (±200 V) output to LTT24 housing: no
Output Ranges	±10 V, ±5 V; ±500 mV, ±250 mV
Coupling	DC
DC Offset	digital
Dynamic Range	100 dB with 20 Bit DAC*
Inter-Channel Phase Difference	< 2 ns
Output Signal Sources	monitoring: online ADC data from analog input replay: recorded ADC data from internal SSD arbitrary function generator: PC data from internal SSD

Specifications are subject to change without notice.